



FT10001

Reset Timer with Fixed Delay and Reset Pulse

Features

- Fixed Reset Delay: 10 Seconds
- One Input Reset Pin
- Open-Drain Output Pin with Fixed 530ms Pulse
- 1.8V to 5.0V Operation ($T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$)
- 1.7V to 5.0V Operation ($T_A = -25^{\circ}\text{C}$ to $+85^{\circ}\text{C}$)
- 1.65V to 5.00V Operation ($T_A = 0^{\circ}\text{C}$ to $+85^{\circ}\text{C}$)
- $<1\mu\text{A}$ I_{CCQ} Consumption
- Zero-Second Test-Mode Enable
- Integrated Pull-Up Resistor on /SRO

Applications

- Cell Phones
- Portable Media Players
- Tablets
- Mobile Devices
- Consumer Medical

Description

The FT10001 is a timer for resetting a mobile device where long reset times are needed. The long delay helps avoid unintended resets caused by accidental key presses. It has a fixed delay of $10 \pm 20\%$ seconds. The DSR pin enables Test Mode operation by immediately forcing /RST1 LOW for factory testing.

The FT10001 has one input for single-button resetting capability. The device has a single open-drain output with 0.5mA pull-down drive.

FT10001 draws minimal I_{CC} current when inactive and functions over a power supply range of 1.65V to 5.00V.

Ordering Information

Part Number	Operating Temperature Range	Package	Packing Method
FT10001L6X	-40°C to $+85^{\circ}\text{C}$	6-Lead, MicroPak™ 1.0 x 1.45mm, JEDEC MO-252	5000 Units on Tape and Reel
FT10001FHX	-40°C to $+85^{\circ}\text{C}$	6-Lead, MicroPak2™ 1.0 x 1.0mm Body, .35mm Pitch	5000 Units on Tape and Reel

Block Diagram

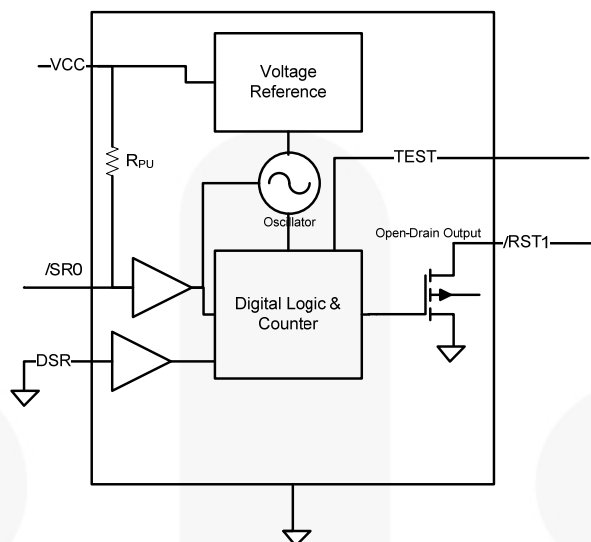


Figure 1. Block Diagram

Pin Configuration

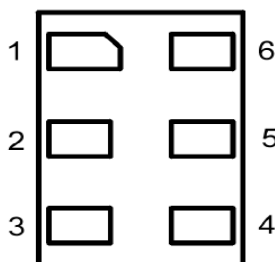


Figure 2. Pad Assignments (Top-Through View)

Pin Definitions

Pin #	Name	Description	
		Normal Operation	Zero-Second Factory-Test Mode
1	/RST1	Open-drain output, active LOW	Open-drain output, active LOW
2	GND	GND	GND
3	/SR0	Reset input with integrated pull-up, active LOW	Reset input with integrated pull-up, active LOW
4	VCC	Power supply	Power supply
5	DSR	Delay selection input; tie to GND during normal operation. ⁽¹⁾	Delay selection input. Pull HIGH to enable Zero-second delay for factory test.
6	TEST	Used for device testing; tie to GND during normal operation.	Used for device testing; tie to GND during normal operation.

Note:

1. This pin must always be tied to either GND or VCC. It must not float.

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Condition	Min.	Max.	Unit
V_{CC}	Supply Voltage		-0.5	7.0	V
V_{IN}	DC Input Voltage	/SR0, DSR	-0.5	7.0	V
V_{OUT}	Output Voltage ⁽²⁾	/RST1	-0.5	7.0	V
I_{IK}	DC Input Diode Current	$V_{IN} < 0V$		-50	mA
I_{OK}	DC Output Diode Current	$V_{OUT} < 0V$		-50	mA
I_{OL}	DC Output Sink Current			+50	mA
I_{CC}	DC V_{CC} or Ground Current per Supply Pin			±100	mA
T_{STG}	Storage Temperature Range		-65	+150	°C
T_J	Junction Temperature Under Bias			+150	°C
T_L	Junction Lead Temperature, Soldering 10 Seconds			+260	°C
P_D	Power Dissipation			5	mW
ESD	Electrostatic Discharge Capability	Human Body Model, JESD22-A114		4	kV
		Charged Device Model, JESD22-C101		2	

Note:

- All output current Absolute Maximum Ratings must be observed.

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to Absolute Maximum Ratings.

Symbol	Parameter	Condition	Min.	Max.	Unit
V_{CC}	Supply Voltage	-40°C to +85°C	1.8	5.0	V
		-25°C to +85°C	1.7	5.0	
		0°C to +85°C	1.65	5.00	
t_{RFC}	V_{CC} Recovery Time After Power Down	$V_{CC}=0V$ After Power Down, Rising to 0.5V	5		ms
V_{IN}	Input Voltage	/SR0	0	5	V
V_{OUT}	Output Voltage	/RST1	0	5	V
I_{OL}	DC Output Sink Current	/RST1, $V_{CC}=2.0V$ to 5.0V		+0.5	mA
T_A	Free-Air Operating Temperature		-40	+85	°C
Θ_{JA}	Thermal Resistance			350	°C/W

DC Electrical Characteristics

Conditions of $T_A = -40^{\circ}\text{C}$ to 80°C with $V_{CC} = 1.8\text{V} - 5.0\text{V}$ OR $T_A = -25^{\circ}\text{C}$ to 85°C with $V_{CC} = 1.7\text{V} - 5.0\text{V}$ OR $T_A = 0^{\circ}\text{C}$ to 85°C with $V_{CC} = 1.65\text{V} - 5.00\text{V}$ produce the performance characteristics below.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
V_{IH}	Input High Voltage	DSR, /SR0	$0.65 \times V_{CC}$			V
V_{IL}	Input Low Voltage	DSR, /SR0			$0.25 \times V_{CC}$	V
V_{OL}	Low Level Output Voltage	RST, $I_{OL} = 500\mu\text{A}$			0.3	V
R_{PU}	Integrated Pull-Up Resistor on /SR0			50		k Ω
I_{IN}	Input Leakage Current /SR0	$V_{IN} = V_{CC}$			± 1	μA
	Input Leakage Current DSR	$0\text{V} \leq V_{IN} \leq 5.0\text{V}$			± 1	
I_{CC}	Quiescent Supply Current (Timer Inactive)	/SR0 = V_{CC}			1	μA
	Dynamic Supply Current (Timer Active)	/SR0 = 0V			200	

AC Electrical Characteristics

Conditions of $T_A = -40^{\circ}\text{C}$ to 80°C with $V_{CC} = 1.8\text{V} - 5.0\text{V}$ OR $T_A = -25^{\circ}\text{C}$ to 85°C with $V_{CC} = 1.7\text{V} - 5.0\text{V}$ OR $T_A = 0^{\circ}\text{C}$ to 85°C with $V_{CC} = 1.65\text{V} - 5.00\text{V}$ produce the performance characteristics below.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
t_{PHL1}	Timer Delay, /SR0 to RST (DSR=0)	$C_L = 5\text{pF}$, $R_L = 5\text{K}\Omega$, See Figure 4	8	10	12	s
t_{REC}	Reset Timeout Delay		420	530	635	ms

Capacitance Specifications

$T_A = +25^{\circ}\text{C}$.

Symbol	Parameter	Condition	Typ.	Unit
C_{IN}	Input Capacitance	$V_{CC} = \text{GND}$	4	pF
C_{OUT}	Output Capacitance	$V_{CC} = 5.0\text{V}$	5	pF

Functional Description

Default operation time N is 10s. If the DSR pin is pulled HIGH prior to V_{CC} ramp, the FT10001 enters Test Mode and the reset output, $/RST1$, is immediately pulled LOW for factory testing. The DSR pin MUST be forced to GND during normal operation. The DSR pin should never be driven HIGH or left to FLOAT during normal operation. The DSR PIN state should never be changed during device operation; it must be biased prior to supplying the V_{CC} supply. If there is a need to use the DSR= V_{CC} Test Mode, the $/SR0$ must be HIGH when the DSR pin is moved from LOW to HIGH to enter Zero-Second Factory-Test Mode. To return to the standard 10-second reset time, the same procedure must be followed with DSR=GND. The DSR pin should never be allowed to change state while the $/SR0$ pin is LOW.

Operation Modes

A low input signal on $/SR0$ starts the oscillator. There are two scenarios for counting: short duration and long duration. In the short-duration scenario, output $/RST1$ is not affected. In the long-duration scenario, the output $/RST1$ goes LOW after $/SR0$ has been held LOW for ≥ 10 s. The $/RST1$ output returns to its original HIGH

state 530ms after time t_{REC} has expired, regardless of the state of $/SR0$. The $/RST1$ output is an open-drain driver. When the count time exceeds time 10s, the $/RST1$ output pulls LOW.

Short Duration ($t_w < 10$ s)

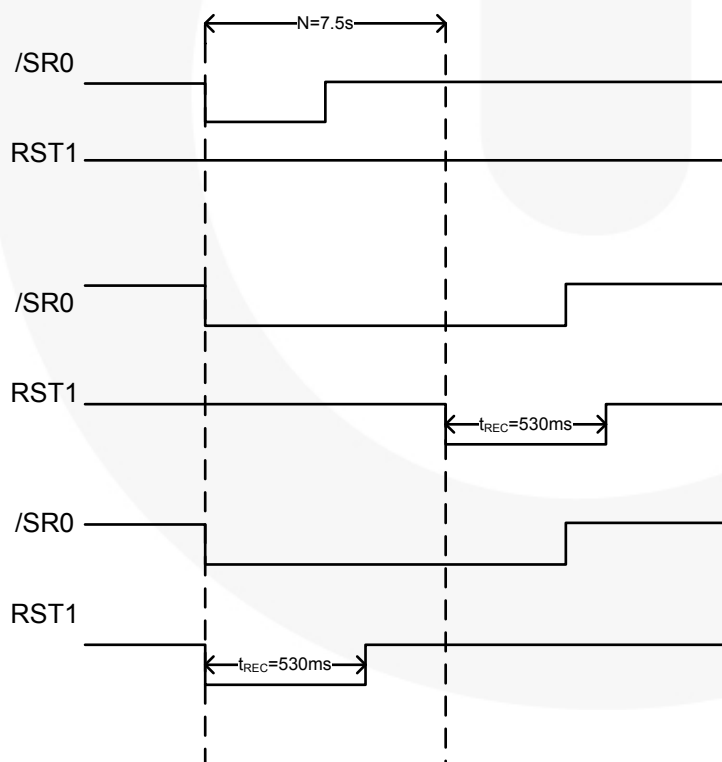
When the $/SR0$ input goes LOW, the internal timer starts counting. If the $/SR0$ input goes HIGH before 10s has elapsed, the timer stops counting and resets and no changes occur on the outputs.

Long Duration ($t_w > 10$ s)

When the $/SR0$ input goes LOW, the internal timer starts counting. If the $/SR0$ input stays LOW for at least 10s, the RST output is enabled and pulled LOW. The output RST is held LOW for t_{REC} , 530ms, as soon as the reset time of 10s is met, regardless of the state of the $/SR0$ pin. When the $/SR0$ input has returned HIGH and t_{REC} has expired, the internal timer resets and awaits the next RESET event.

Zero-Second Test Mode

$/RST1$ goes LOW immediately after $/SR0$ goes LOW.



**Short-Duration,
Normal Operation**
 $/RST1$ never goes LOW because
 $/SR0$ LOW duration does not meet
requirement: Reset Time $N=10$ s

**Long-Duration,
Normal Operation**
 $/RST1$ goes LOW because
 $/SR0$ LOW duration exceeds
requirement: Reset Time $N=10$ s

Zero-Second Factory-Test Mode
 $/RST1$ goes LOW immediately
after $/SR0$ goes LOW

Figure 3. Reset Timing Waveforms

AC Test Circuit and Waveforms

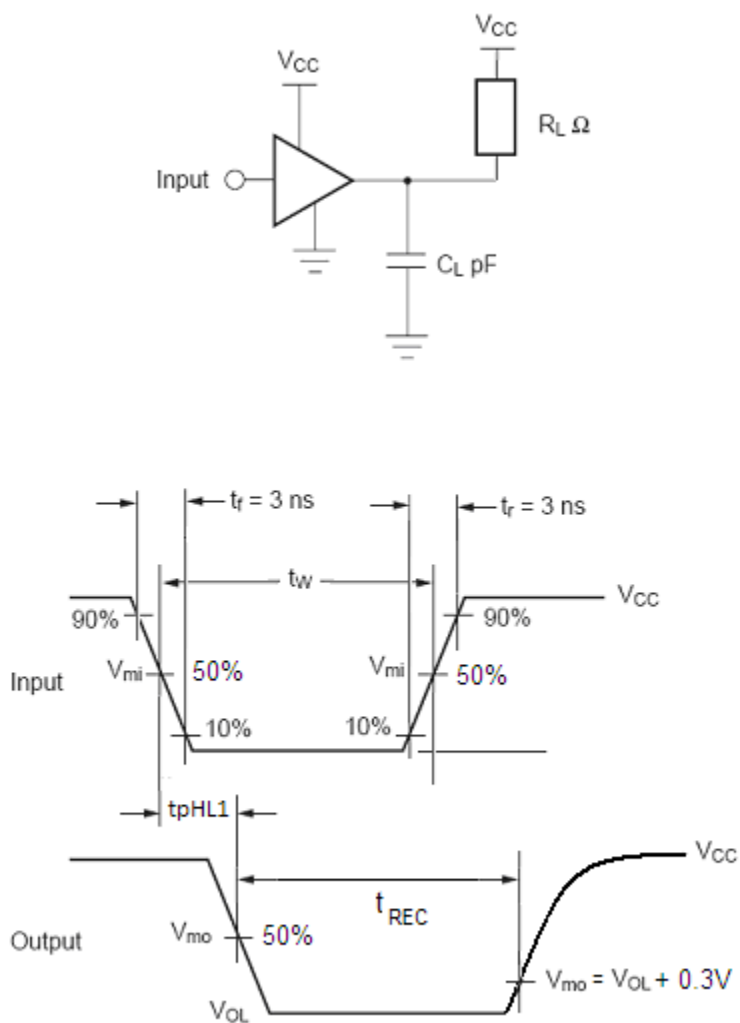


Figure 4. AC Test Circuit and Waveforms for /RST1 Output ST Output

Notes:

- Figure 5. 6-Lead MicroPak™ 1.0 x 1.45mm, JEDEC MO-252**

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Physical Dimensions

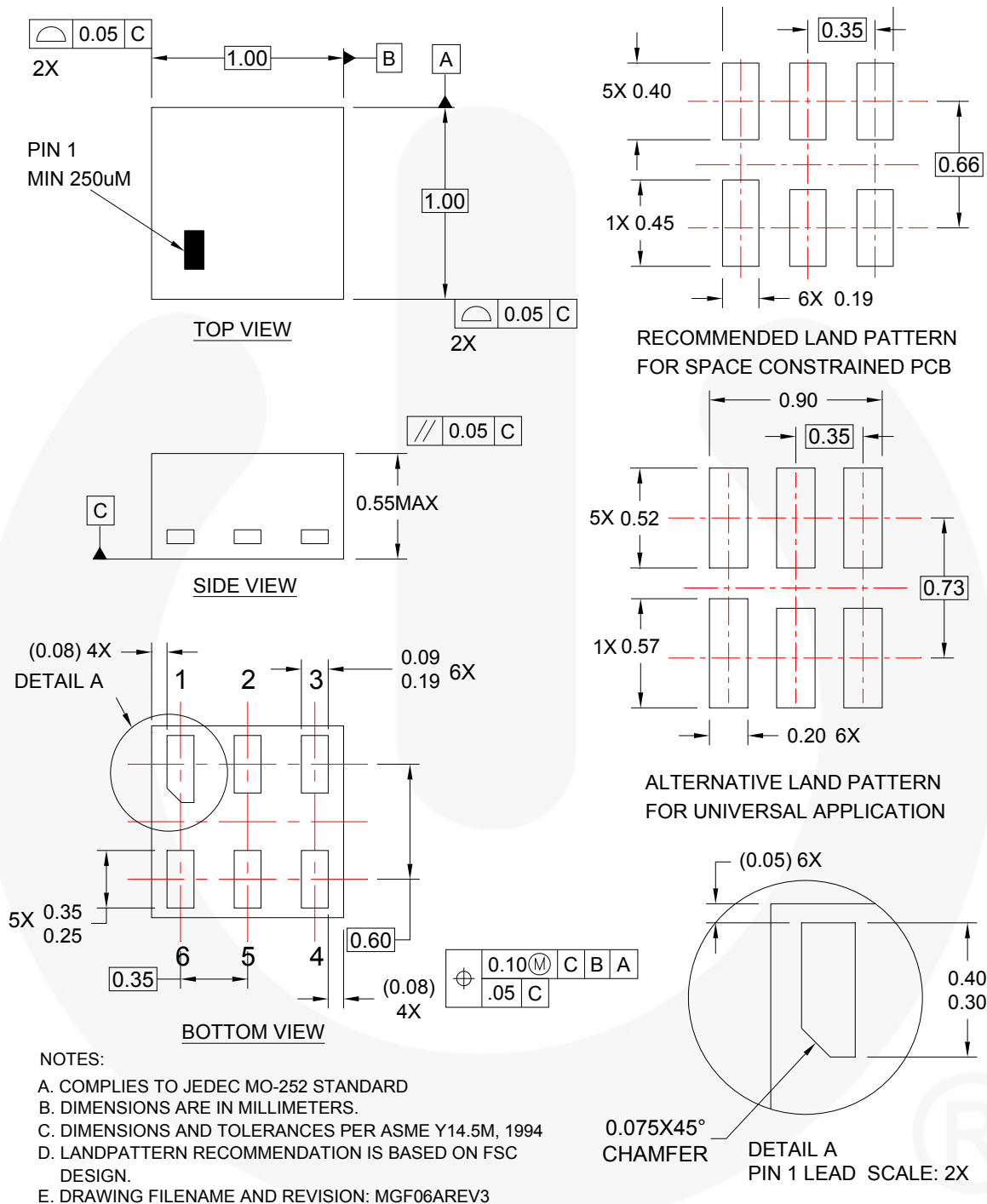


Figure 6. 6-Lead MicroPak2™ 1.0 x 1.0mm, .35mm Pitch

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Rev. I61

Revisions

Rev 0.0	8/1/11	Sean Ryan	Initial Rev – created from FT7521 datasheet
Rev 0.1	8/11/11	Sean Ryan	Updated the t_{REC} to align with reset time of 10sec.
Rev 0.2	8/24/11	Alvan Lam	Added micropak2 information and marketing drawing
Rev 0.3	8/25/11	Alvan Lam	Updated the NMOS symbol in block diagram
Rev 0.4	9/6/11	Alvan Lam	Created revision table instead of using Hidden Text
Rev 1.0.0	12/6/11	Alvan Lam	Changed ABS Max to 7V, initial datasheet released by Techdoc
Rev 1.0.1	12/14/11	Alvan Lam	Added 1.7/-25C condition to align FT7521 datasheet

